

# DATA SHEET

## **BF1212; BF1212R; BF1212WR** N-channel dual-gate MOS-FETs

Product specification

2003 Nov 14



# N-channel dual-gate MOS-FETs

## BF1212; BF1212R; BF1212WR

### FEATURES

- Short channel transistor with high forward transfer admittance to input capacitance ratio
- Low noise gain controlled amplifier
- Excellent low frequency noise performance
- Partly internal self-biasing circuit to ensure good cross-modulation performance during AGC and good DC stabilization.

### APPLICATIONS

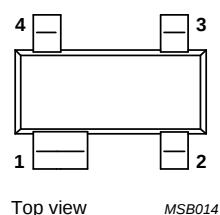
- Gain controlled low noise VHF and UHF amplifiers for 5 V digital and analog television tuner applications.

### DESCRIPTION

Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1212, BF1212R and BF1212WR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.

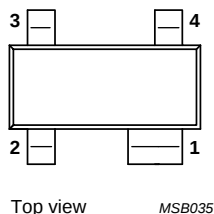
### PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1   | source      |
| 2   | drain       |
| 3   | gate 2      |
| 4   | gate 1      |



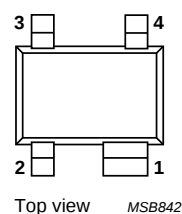
BF1212; marking code: LGp

Fig.1 Simplified outline (SOT143B).



BF1212R; marking code: LKp

Fig.2 Simplified outline (SOT143R).



BF1212WR; marking code: ML

Fig.3 Simplified outline (SOT343R).

### QUICK REFERENCE DATA

| SYMBOL       | PARAMETER                    | CONDITIONS                              | MIN. | TYP. | MAX. | UNIT       |
|--------------|------------------------------|-----------------------------------------|------|------|------|------------|
| $V_{DS}$     | drain-source voltage         |                                         | –    | –    | 6    | V          |
| $I_D$        | drain current                |                                         | –    | –    | 30   | mA         |
| $P_{tot}$    | total power dissipation      |                                         | –    | –    | 180  | mW         |
| $ y_{fs} $   | forward transfer admittance  |                                         | 28   | 33   | 43   | mS         |
| $C_{ig1-ss}$ | input capacitance at gate 1  |                                         | –    | 1.7  | 2.2  | pF         |
| $C_{rss}$    | reverse transfer capacitance | $f = 1 \text{ MHz}$                     | –    | 15   | 30   | fF         |
| $F$          | noise figure                 | $f = 800 \text{ MHz}$                   | –    | 1.1  | 1.8  | dB         |
| $X_{mod}$    | cross-modulation             | input level for $k = 1 \%$ at 40 dB AGC | 100  | 104  | –    | dB $\mu$ V |
| $T_j$        | junction temperature         |                                         | –    | –    | 150  | °C         |

## N-channel dual-gate MOS-FETs

BF1212; BF1212R; BF1212WR

**CAUTION**

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.

**ORDERING INFORMATION**

| TYPE NUMBER | PACKAGE |                                                           |         |
|-------------|---------|-----------------------------------------------------------|---------|
|             | NAME    | DESCRIPTION                                               | VERSION |
| BF1212      | –       | plastic surface mounted package; 4 leads                  | SOT143B |
| BF1212R     | –       | plastic surface mounted package; reverse pinning; 4 leads | SOT143R |
| BF1212WR    | –       | plastic surface mounted package; reverse pinning; 4 leads | SOT343R |

**LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL    | PARAMETER               | CONDITIONS                                      | MIN. | MAX.     | UNIT               |
|-----------|-------------------------|-------------------------------------------------|------|----------|--------------------|
| $V_{DS}$  | drain-source voltage    |                                                 | –    | 6        | V                  |
| $I_D$     | drain current (DC)      |                                                 | –    | 30       | mA                 |
| $I_{G1}$  | gate 1 current          |                                                 | –    | $\pm 10$ | mA                 |
| $I_{G2}$  | gate 2 current          |                                                 | –    | $\pm 10$ | mA                 |
| $P_{tot}$ | total power dissipation |                                                 |      |          |                    |
|           | BF1212; BF1212R         | $T_s \leq 116\text{ }^{\circ}\text{C}$ ; note 1 | –    | 180      | mW                 |
|           | BF1212WR                | $T_s \leq 122\text{ }^{\circ}\text{C}$ ; note 1 | –    | 180      | mW                 |
| $T_{stg}$ | storage temperature     |                                                 | –65  | +150     | $^{\circ}\text{C}$ |
| $T_j$     | junction temperature    |                                                 | –    | 150      | $^{\circ}\text{C}$ |

**Note**

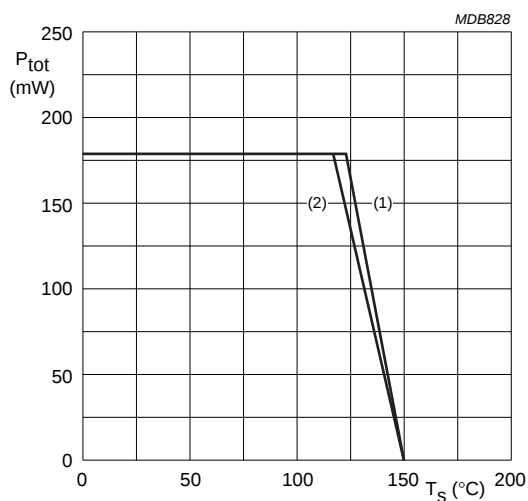
1.  $T_s$  is the temperature of the soldering point of the source lead.

**THERMAL CHARACTERISTICS**

| SYMBOL        | PARAMETER                                           | VALUE | UNIT |
|---------------|-----------------------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point |       |      |
|               | BF1212; BF1212R                                     | 185   | K/W  |
|               | BF1212WR                                            | 155   | K/W  |

## N-channel dual-gate MOS-FETs

## BF1212; BF1212R; BF1212WR



- (1) BF1212WR.  
(2) BF1212; BF1212R.

Fig. 4 Power derating curve.

### STATIC CHARACTERISTICS

$T_j = 25^\circ\text{C}$  unless otherwise specified.

| SYMBOL          | PARAMETER                       | CONDITIONS                                                                               | MIN. | MAX. | UNIT |
|-----------------|---------------------------------|------------------------------------------------------------------------------------------|------|------|------|
| $V_{(BR)DSS}$   | drain-source breakdown voltage  | $V_{G1-S} = V_{G2-S} = 0\text{ V}$ ; $I_D = 10\text{ }\mu\text{A}$                       | 6    | —    | V    |
| $V_{(BR)G1-SS}$ | gate 1-source breakdown voltage | $V_{G2-S} = V_{DS} = 0\text{ V}$ ; $I_{G1-S} = 10\text{ mA}$                             | 6    | 10   | V    |
| $V_{(BR)G2-SS}$ | gate 2-source breakdown voltage | $V_{G1-S} = V_{DS} = 0\text{ V}$ ; $I_{G2-S} = 10\text{ mA}$                             | 6    | 10   | V    |
| $V_{(F)S-G1}$   | forward source-gate 1 voltage   | $V_{G2-S} = V_{DS} = 0\text{ V}$ ; $I_{S-G1} = 10\text{ mA}$                             | 0.5  | 1.5  | V    |
| $V_{(F)S-G2}$   | forward source-gate 2 voltage   | $V_{G1-S} = V_{DS} = 0\text{ V}$ ; $I_{S-G2} = 10\text{ mA}$                             | 0.5  | 1.5  | V    |
| $V_{G1-S(th)}$  | gate 1-source threshold voltage | $V_{G2-S} = 4\text{ V}$ ; $V_{DS} = 5\text{ V}$ ; $I_D = 100\text{ }\mu\text{A}$         | 0.3  | 1.0  | V    |
| $V_{G2-S(th)}$  | gate 2-source threshold voltage | $V_{G1-S} = 5\text{ V}$ ; $V_{DS} = 5\text{ V}$ ; $I_D = 100\text{ }\mu\text{A}$         | 0.35 | 1.0  | V    |
| $I_{DSX}$       | drain-source current            | $V_{G2-S} = 4\text{ V}$ ; $V_{DS} = 5\text{ V}$ ; $R_{G1} = 150\text{ k}\Omega$ ; note 1 | 8    | 16   | mA   |
| $I_{G1-S}$      | gate 1 cut-off current          | $V_{G2-S} = V_{DS} = 0\text{ V}$ ; $V_{G1-S} = 5\text{ V}$                               | —    | 50   | nA   |
| $I_{G2-S}$      | gate 2 cut-off current          | $V_{G1-S} = V_{DS} = 0\text{ V}$ ; $V_{G2-S} = 4\text{ V}$                               | —    | 20   | nA   |

### Note

1.  $R_{G1}$  connects  $G_1$  to  $V_{GG} = 5\text{ V}$ .

## N-channel dual-gate MOS-FETs

## BF1212; BF1212R; BF1212WR

**DYNAMIC CHARACTERISTICS**

Common source;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $V_{DS} = 5\text{ V}$ ;  $I_D = 12\text{ mA}$ ; unless otherwise specified.

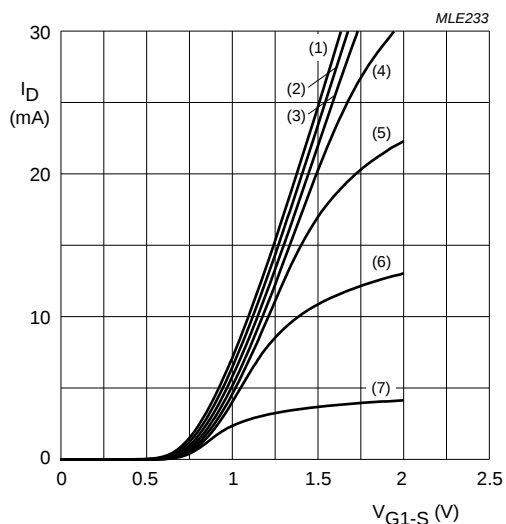
| SYMBOL       | PARAMETER                    | CONDITIONS                                                                                                   | MIN. | TYP. | MAX. | UNIT       |
|--------------|------------------------------|--------------------------------------------------------------------------------------------------------------|------|------|------|------------|
| $ y_{fs} $   | forward transfer admittance  | pulsed; $T_j = 25\text{ }^{\circ}\text{C}$                                                                   | 28   | 33   | 43   | mS         |
| $C_{ig1-ss}$ | input capacitance at gate 1  | $f = 1\text{ MHz}$                                                                                           | –    | 1.7  | 2.2  | pF         |
| $C_{ig2-ss}$ | input capacitance at gate 2  | $f = 1\text{ MHz}$                                                                                           | –    | 1.1  | –    | pF         |
| $C_{oss}$    | output capacitance           | $f = 1\text{ MHz}$                                                                                           | –    | 0.9  | –    | pF         |
| $C_{rss}$    | reverse transfer capacitance | $f = 1\text{ MHz}$                                                                                           | –    | 15   | 30   | fF         |
| F            | noise figure                 | $f = 11\text{ MHz}$ ; $G_S = 20\text{ mS}$ ; $B_S = 0$                                                       | –    | 4    | –    | dB         |
|              |                              | $f = 400\text{ MHz}$ ; $Y_S = Y_{S(opt)}$                                                                    | –    | 0.9  | 1.6  | dB         |
|              |                              | $f = 800\text{ MHz}$ ; $Y_S = Y_{S(opt)}$                                                                    | –    | 1.1  | 1.8  | dB         |
| $G_{tr}$     | power gain                   | $f = 200\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $B_S = B_{S(opt)}$ ; $G_L = 0.5\text{ mS}$ ; $B_L = B_{L(opt)}$ | –    | 35   | –    | dB         |
|              |                              | $f = 400\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $B_S = B_{S(opt)}$ ; $G_L = 1\text{ mS}$ ; $B_L = B_{L(opt)}$   | –    | 30   | –    | dB         |
|              |                              | $f = 800\text{ MHz}$ ; $G_S = 3.3\text{ mS}$ ; $B_S = B_{S(opt)}$ ; $G_L = 1\text{ mS}$ ; $B_L = B_{L(opt)}$ | –    | 25   | –    | dB         |
| $X_{mod}$    | cross-modulation             | input level for $k = 1\%$ ; $f_w = 50\text{ MHz}$ ; $f_{unw} = 60\text{ MHz}$ ; note 1                       |      |      |      |            |
|              |                              | at 0 dB AGC                                                                                                  | 90   | –    | –    | dB $\mu$ V |
|              |                              | at 10 dB AGC                                                                                                 | –    | 89   | –    | dB $\mu$ V |
|              |                              | at 40 dB AGC                                                                                                 | 100  | 104  | –    | dB $\mu$ V |

**Note**

1. Measured in test circuit Fig.21.

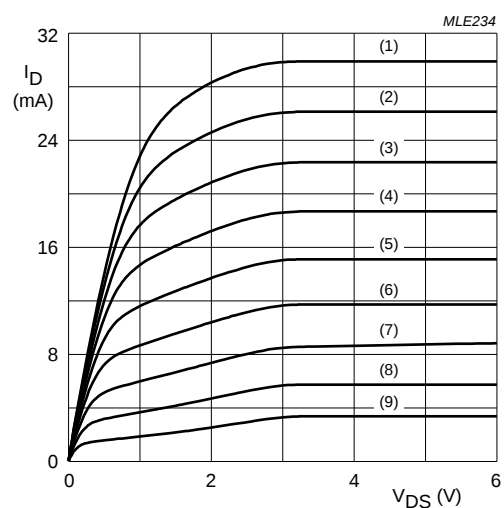
## N-channel dual-gate MOS-FETs

## BF1212; BF1212R; BF1212WR



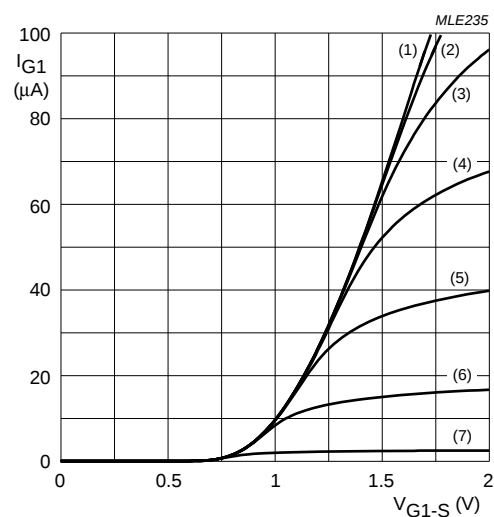
- (1)  $V_{G2-S} = 4 \text{ V.}$  (5)  $V_{G2-S} = 2 \text{ V.}$   $V_{DS} = 5 \text{ V.}$   
 (2)  $V_{G2-S} = 3.5 \text{ V.}$  (6)  $V_{G2-S} = 1.5 \text{ V.}$   $T_j = 25^\circ \text{C.}$   
 (3)  $V_{G2-S} = 3 \text{ V.}$  (7)  $V_{G2-S} = 1 \text{ V.}$   
 (4)  $V_{G2-S} = 2.5 \text{ V.}$

Fig.5 Transfer characteristics; typical values.



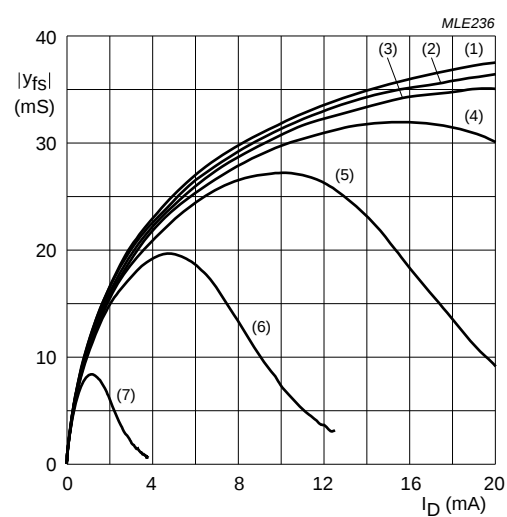
- (1)  $V_{G1-S} = 1.6 \text{ V.}$  (6)  $V_{G1-S} = 1.1 \text{ V.}$   $V_{G2-S} = 4 \text{ V.}$   
 (2)  $V_{G1-S} = 1.5 \text{ V.}$  (7)  $V_{G1-S} = 1.0 \text{ V.}$   $T_j = 25^\circ \text{C.}$   
 (3)  $V_{G1-S} = 1.4 \text{ V.}$  (8)  $V_{G1-S} = 0.9 \text{ V.}$   
 (4)  $V_{G1-S} = 1.3 \text{ V.}$  (9)  $V_{G1-S} = 0.8 \text{ V.}$   
 (5)  $V_{G1-S} = 1.2 \text{ V.}$

Fig.6 Output characteristics; typical values.



- (1)  $V_{G2-S} = 4 \text{ V.}$  (5)  $V_{G2-S} = 2 \text{ V.}$   $V_{DS} = 5 \text{ V.}$   
 (2)  $V_{G2-S} = 3.5 \text{ V.}$  (6)  $V_{G2-S} = 1.5 \text{ V.}$   $T_j = 25^\circ \text{C.}$   
 (3)  $V_{G2-S} = 3 \text{ V.}$  (7)  $V_{G2-S} = 1 \text{ V.}$   
 (4)  $V_{G2-S} = 2.5 \text{ V.}$

Fig.7 Gate 1 current as a function of gate 1 voltage; typical values.

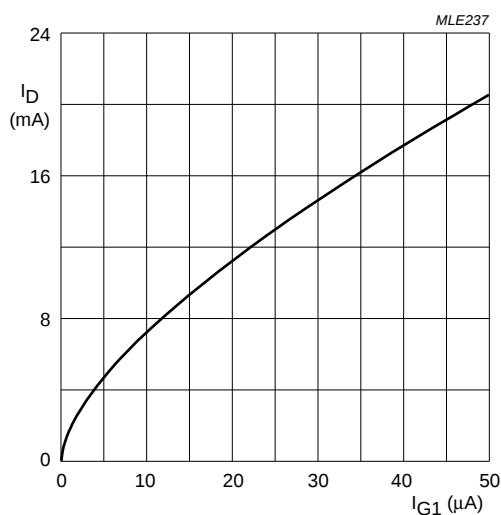


- (1)  $V_{G2-S} = 4 \text{ V.}$  (5)  $V_{G2-S} = 2 \text{ V.}$   $V_{DS} = 5 \text{ V.}$   
 (2)  $V_{G2-S} = 3.5 \text{ V.}$  (6)  $V_{G2-S} = 1.5 \text{ V.}$   $T_j = 25^\circ \text{C.}$   
 (3)  $V_{G2-S} = 3 \text{ V.}$  (7)  $V_{G2-S} = 1 \text{ V.}$   
 (4)  $V_{G2-S} = 2.5 \text{ V.}$

Fig.8 Forward transfer admittance as a function of drain current; typical values.

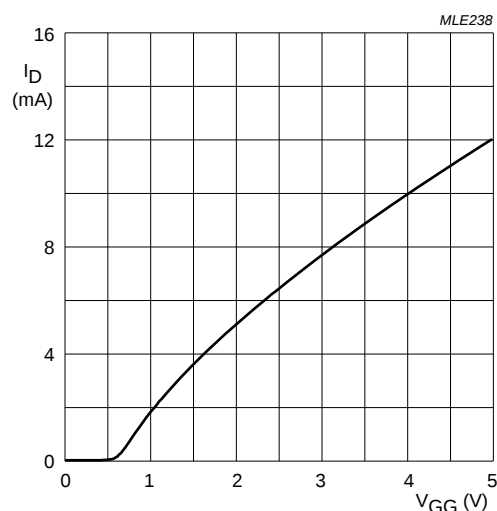
## N-channel dual-gate MOS-FETs

## BF1212; BF1212R; BF1212WR



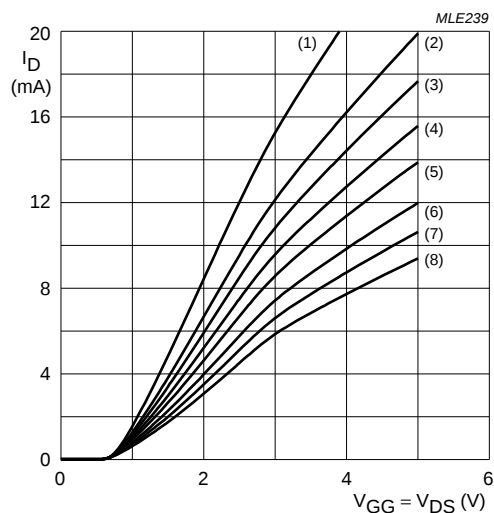
$V_{DS} = 5 \text{ V}$ ;  $V_{G2-S} = 4 \text{ V}$ .  
 $T_J = 25 \text{ }^{\circ}\text{C}$ .

Fig.9 Drain current as a function of gate 1 current; typical values.



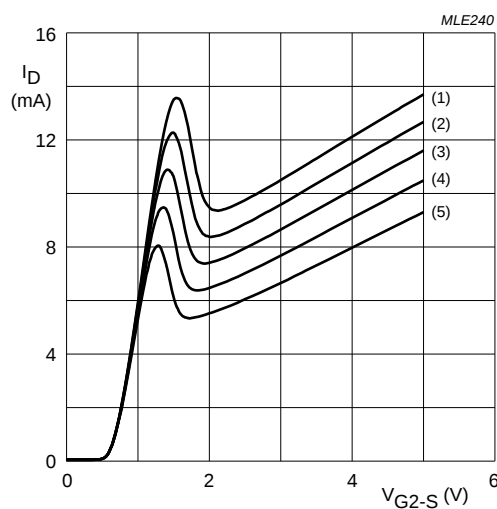
$V_{DS} = 5 \text{ V}$ ;  $V_{G2-S} = 4 \text{ V}$ ;  $T_J = 25 \text{ }^{\circ}\text{C}$ .  
 $R_{G1} = 150 \text{ k}\Omega$  (connected to  $V_{GG}$ ); see Fig.21.

Fig.10 Drain current as a function of gate 1 supply voltage; typical values.



(1)  $R_{G1} = 47 \text{ k}\Omega$ . (5)  $R_{G1} = 120 \text{ k}\Omega$ .  $V_{G2-S} = 4 \text{ V}$ ;  $T_J = 25 \text{ }^{\circ}\text{C}$ .  
 (2)  $R_{G1} = 56 \text{ k}\Omega$ . (6)  $R_{G1} = 150 \text{ k}\Omega$ .  $R_{G1}$  connected to  $V_{GG}$ ;  
 (3)  $R_{G1} = 82 \text{ k}\Omega$ . (7)  $R_{G1} = 180 \text{ k}\Omega$ . see Fig.21.  
 (4)  $R_{G1} = 100 \text{ k}\Omega$ . (8)  $R_{G1} = 220 \text{ k}\Omega$ .

Fig.11 Drain current as a function of gate 1 and drain supply voltage; typical values.

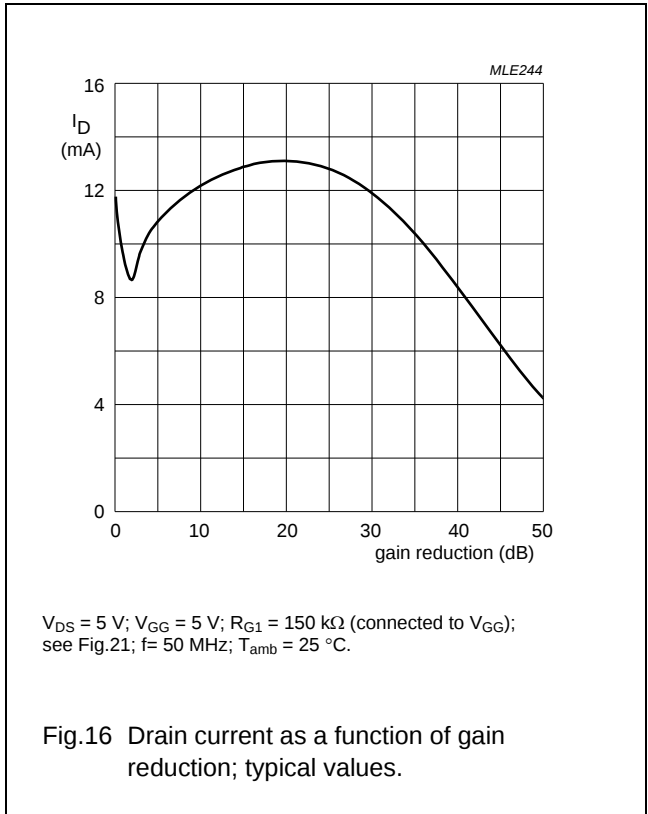
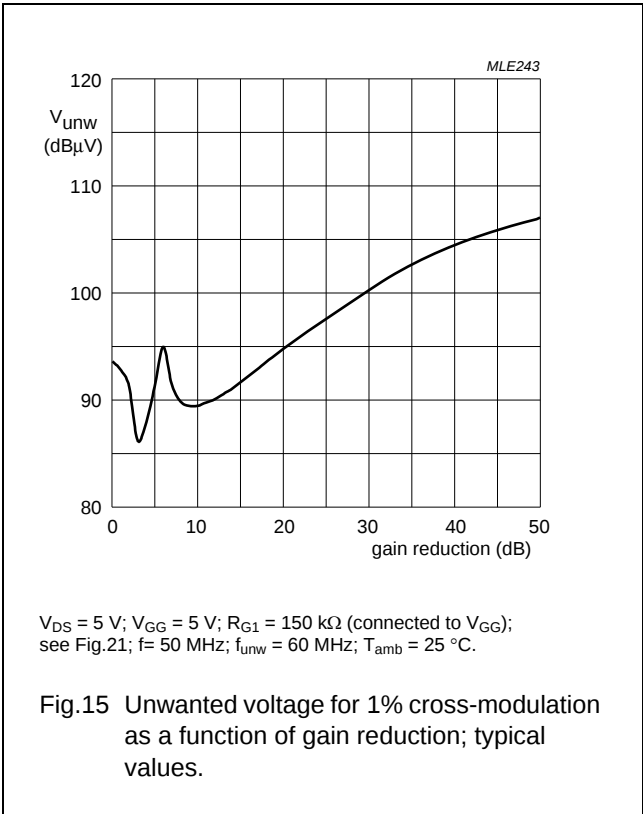
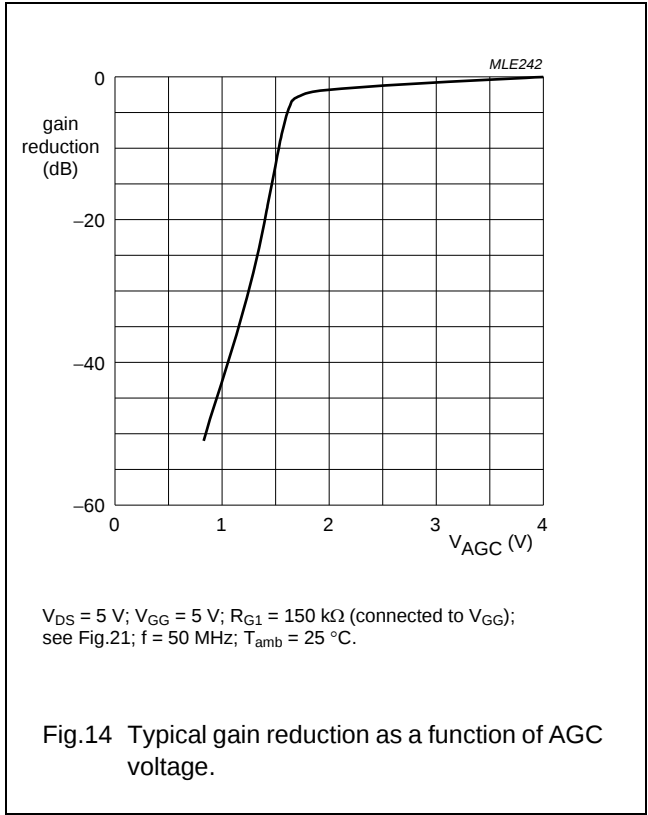
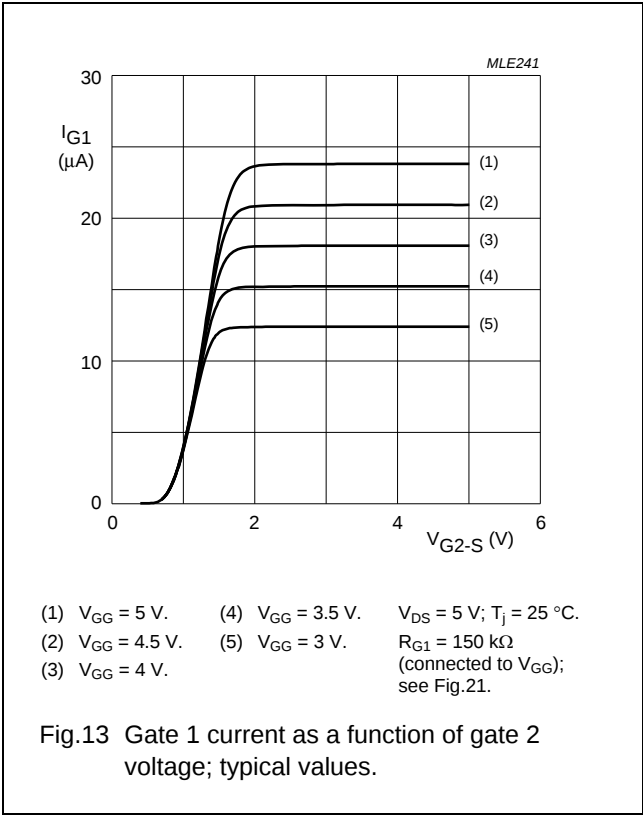


(1)  $V_{GG} = 5 \text{ V}$ . (4)  $V_{GG} = 3.5 \text{ V}$ .  $V_{DS} = 5 \text{ V}$ ;  $T_J = 25 \text{ }^{\circ}\text{C}$ .  
 (2)  $V_{GG} = 4.5 \text{ V}$ . (5)  $V_{GG} = 3 \text{ V}$ .  $R_{G1} = 150 \text{ k}\Omega$   
 (3)  $V_{GG} = 4 \text{ V}$ . (connected to  $V_{GG}$ ); see Fig.21.

Fig.12 Drain current as a function of gate 2 voltage; typical values.

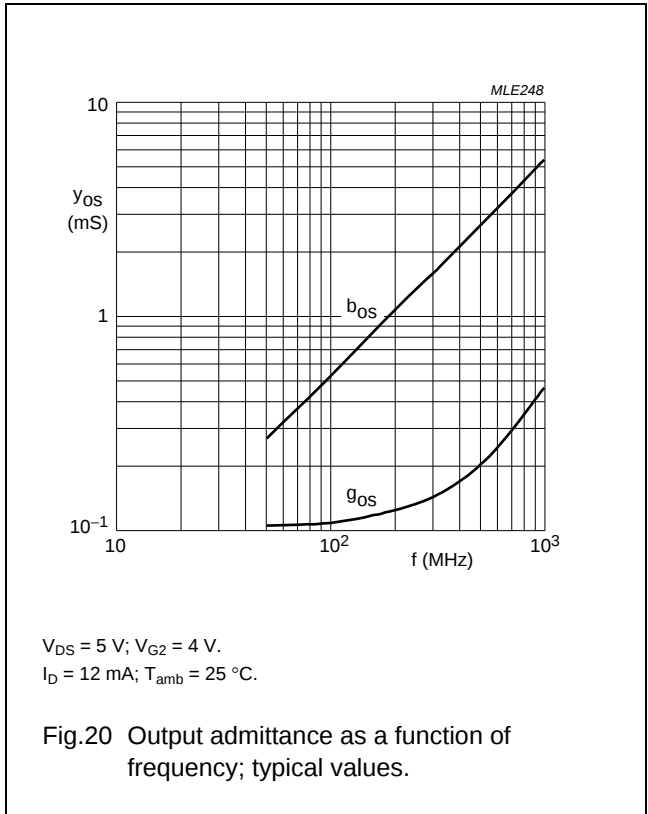
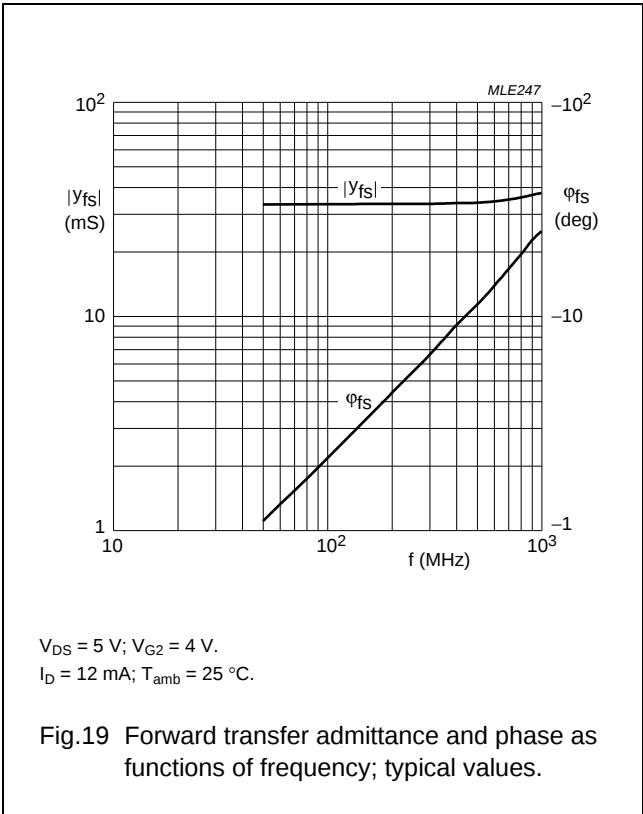
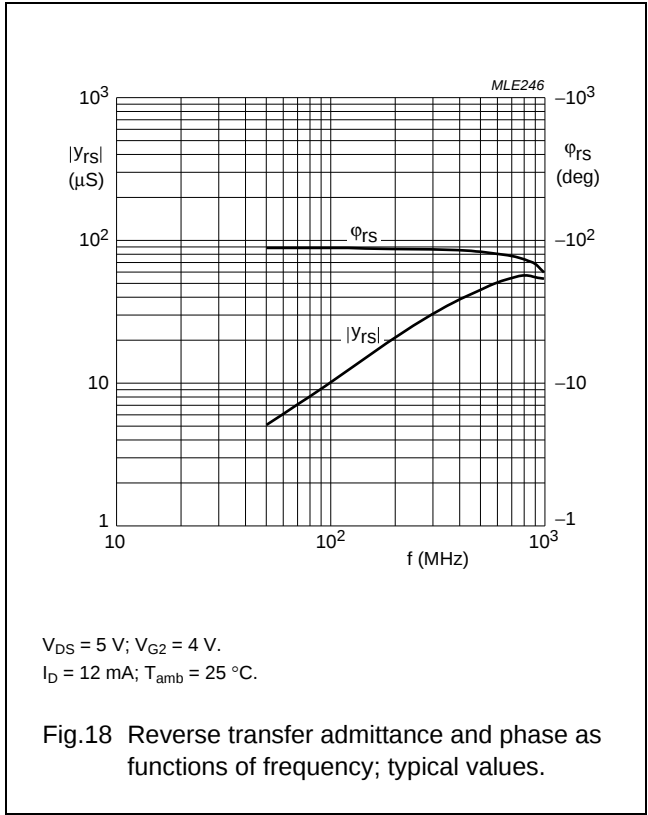
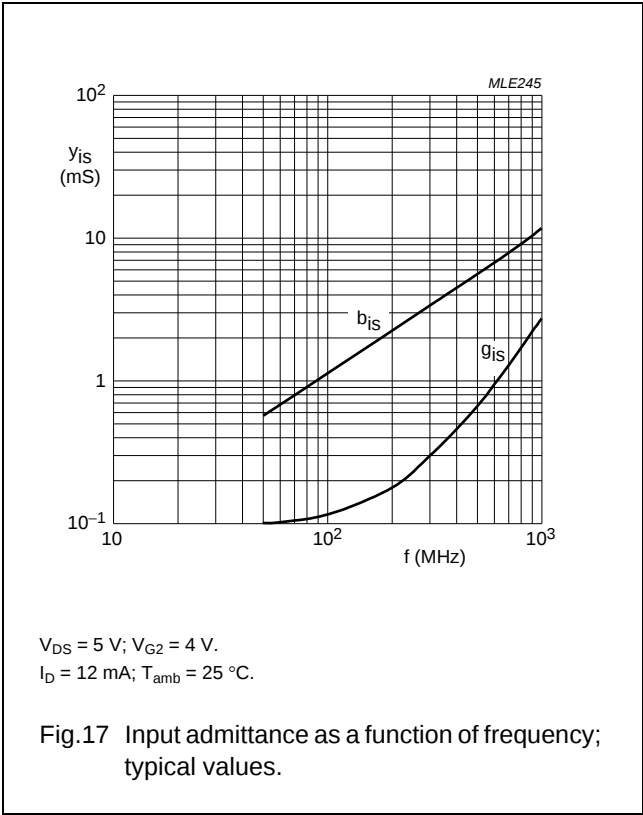
N-channel dual-gate MOS-FETs

BF1212; BF1212R; BF1212WR



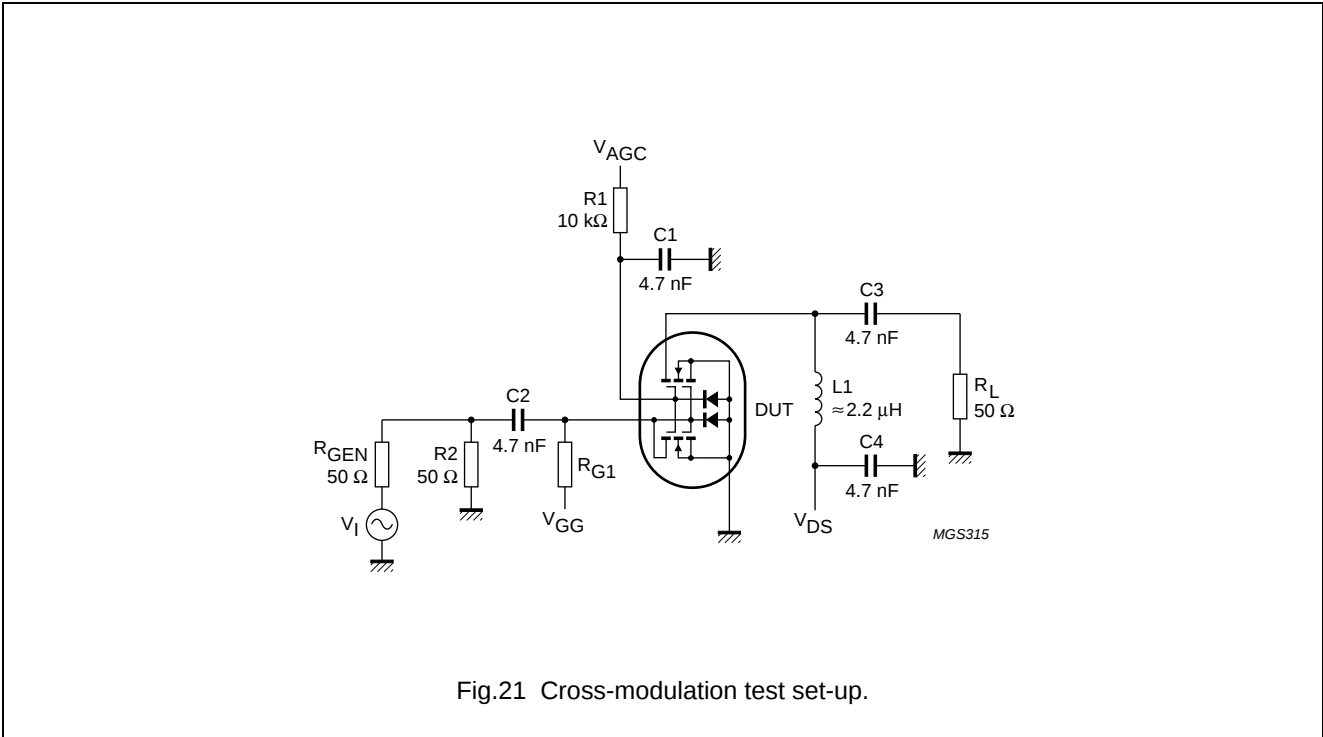
N-channel dual-gate MOS-FETs

BF1212; BF1212R; BF1212WR



N-channel dual-gate MOS-FETs

BF1212; BF1212R; BF1212WR



**Table 1** Scattering parameters:  $V_{DS} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_D = 12\text{ mA}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$

| f<br>(MHz) | S <sub>11</sub>      |                | S <sub>21</sub>      |                | S <sub>12</sub>      |                | S <sub>22</sub>      |                |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|
|            | MAGNITUDE<br>(ratio) | ANGLE<br>(deg) | MAGNITUDE<br>(ratio) | ANGLE<br>(deg) | MAGNITUDE<br>(ratio) | ANGLE<br>(deg) | MAGNITUDE<br>(ratio) | ANGLE<br>(deg) |
| 50         | 0.990                | −3.39          | 3.288                | 176.5          | 0.0005               | 86.9           | 0.990                | −1.66          |
| 100        | 0.988                | −6.76          | 3.280                | 173.0          | 0.0011               | 85.6           | 0.990                | −3.30          |
| 200        | 0.983                | −13.40         | 3.261                | 166.1          | 0.0021               | 81.2           | 0.991                | −6.62          |
| 300        | 0.974                | −19.86         | 3.218                | 159.0          | 0.0030               | 77.5           | 0.991                | −9.92          |
| 400        | 0.969                | −26.46         | 3.205                | 152.6          | 0.0039               | 74.6           | 0.994                | −13.30         |
| 500        | 0.958                | −32.73         | 3.141                | 145.9          | 0.0045               | 72.4           | 0.994                | −16.56         |
| 600        | 0.947                | −38.83         | 3.086                | 139.5          | 0.0049               | 70.9           | 0.993                | −19.77         |
| 700        | 0.936                | −44.75         | 3.017                | 133.1          | 0.0051               | 69.5           | 0.991                | −22.78         |
| 800        | 0.924                | −50.51         | 2.949                | 126.9          | 0.0051               | 69.9           | 0.981                | −25.77         |
| 900        | 0.910                | −56.18         | 2.870                | 120.5          | 0.0049               | 69.8           | 0.984                | −28.72         |
| 1000       | 0.896                | −61.64         | 2.785                | 114.7          | 0.0045               | 72.7           | 0.980                | −31.77         |

**Table 2** Noise data:  $V_{DS} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_D = 12\text{ mA}$ ;  $T_{amb} = 25\text{ }^{\circ}\text{C}$

| f<br>(MHz) | F <sub>min</sub><br>(dB) | Γ <sub>opt</sub> |       | R <sub>n</sub><br>(Ω) |
|------------|--------------------------|------------------|-------|-----------------------|
|            |                          | (ratio)          | (deg) |                       |
| 400        | 0.9                      | 0.695            | 13.87 | 28.5                  |
| 800        | 1.1                      | 0.634            | 30.30 | 32.85                 |

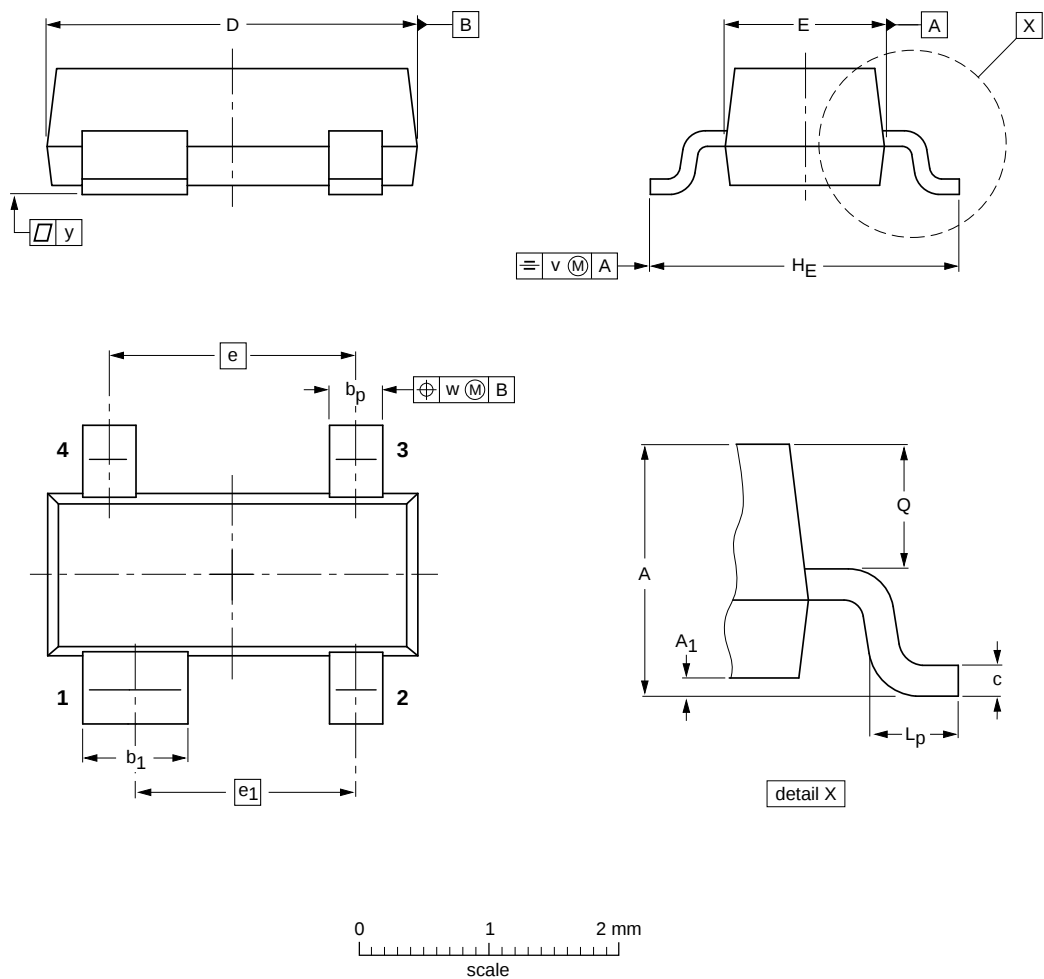
N-channel dual-gate MOS-FETs

BF1212; BF1212R; BF1212WR

PACKAGE OUTLINES

Plastic surface-mounted package; 4 leads

SOT143B



DIMENSIONS (mm are the original dimensions)

| UNIT | A          | A <sub>1</sub><br>max | b <sub>p</sub> | b <sub>1</sub> | c            | D          | E          | e   | e <sub>1</sub> | H <sub>E</sub> | L <sub>p</sub> | Q            | v   | w   | y   |
|------|------------|-----------------------|----------------|----------------|--------------|------------|------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm   | 1.1<br>0.9 | 0.1                   | 0.48<br>0.38   | 0.88<br>0.78   | 0.15<br>0.09 | 3.0<br>2.8 | 1.4<br>1.2 | 1.9 | 1.7            | 2.5<br>2.1     | 0.45<br>0.15   | 0.55<br>0.45 | 0.2 | 0.1 | 0.1 |

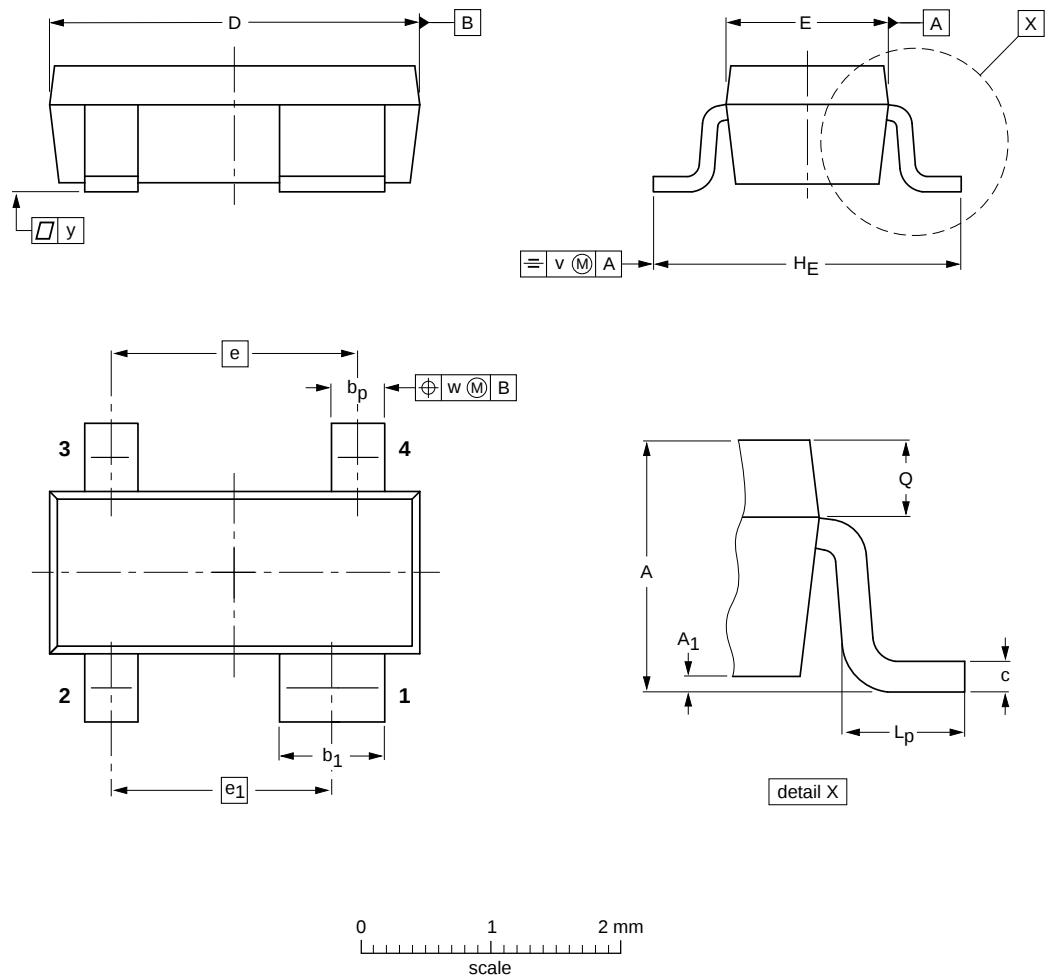
| OUTLINE<br>VERSION | REFERENCES |       |       |  | EUROPEAN<br>PROJECTION | ISSUE DATE           |
|--------------------|------------|-------|-------|--|------------------------|----------------------|
|                    | IEC        | JEDEC | JEITA |  |                        |                      |
| SOT143B            |            |       |       |  |                        | 04-11-16<br>06-03-16 |

N-channel dual-gate MOS-FETs

BF1212; BF1212R; BF1212WR

Plastic surface-mounted package; reverse pinning; 4 leads

SOT143R



DIMENSIONS (mm are the original dimensions)

| UNIT | A          | A <sub>1</sub><br>max | b <sub>p</sub> | b <sub>1</sub> | c            | D          | E          | e   | e <sub>1</sub> | H <sub>E</sub> | L <sub>p</sub> | Q            | v   | w   | y   |
|------|------------|-----------------------|----------------|----------------|--------------|------------|------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm   | 1.1<br>0.9 | 0.1                   | 0.48<br>0.38   | 0.88<br>0.78   | 0.15<br>0.09 | 3.0<br>2.8 | 1.4<br>1.2 | 1.9 | 1.7            | 2.5<br>2.1     | 0.55<br>0.25   | 0.45<br>0.25 | 0.2 | 0.1 | 0.1 |

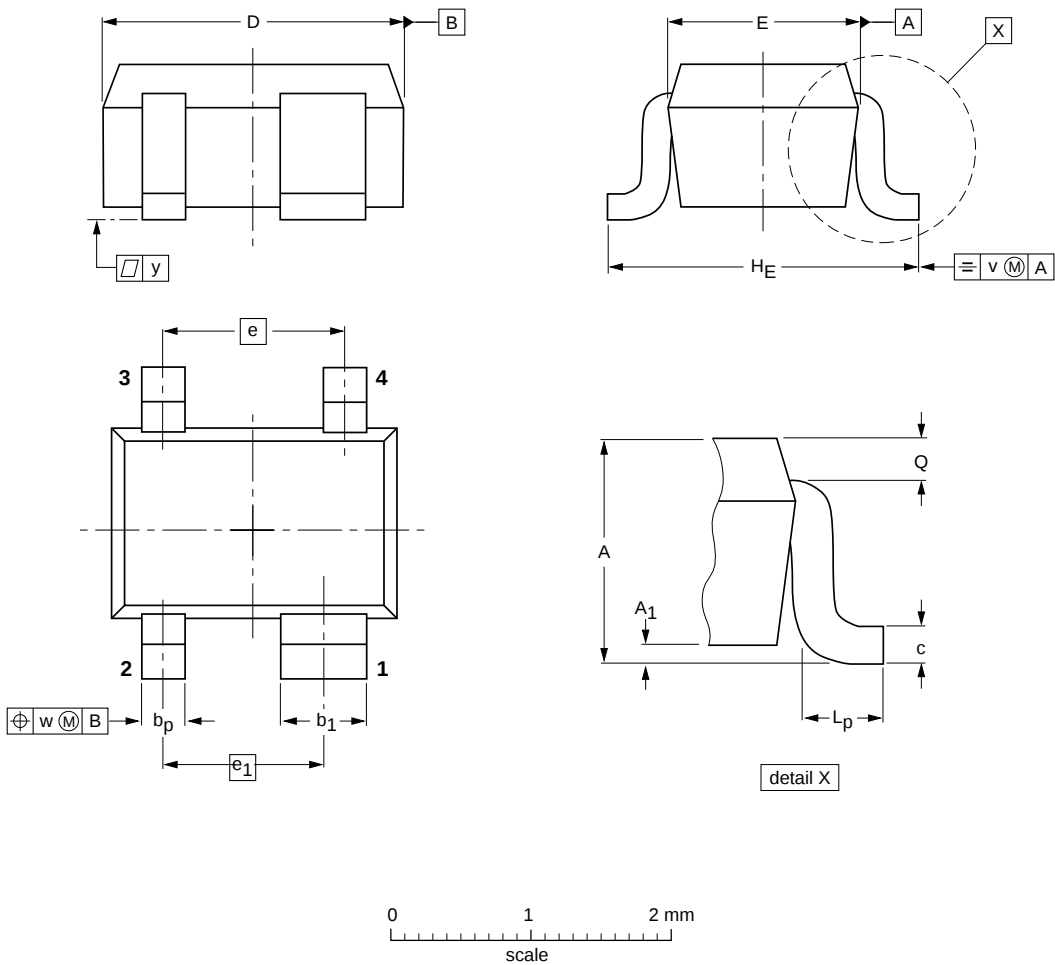
| OUTLINE<br>VERSION | REFERENCES |       |         |  | EUROPEAN<br>PROJECTION | ISSUE DATE           |
|--------------------|------------|-------|---------|--|------------------------|----------------------|
|                    | IEC        | JEDEC | JEITA   |  |                        |                      |
| SOT143R            |            |       | SC-61AA |  |                        | 04-11-16<br>06-03-16 |

N-channel dual-gate MOS-FETs

BF1212; BF1212R; BF1212WR

Plastic surface-mounted package; reverse pinning; 4 leads

SOT343R



DIMENSIONS (mm are the original dimensions)

| UNIT | A          | A <sub>1</sub><br>max | b <sub>p</sub> | b <sub>1</sub> | c            | D          | E            | e   | e <sub>1</sub> | H <sub>E</sub> | L <sub>p</sub> | Q            | v   | w   | y   |
|------|------------|-----------------------|----------------|----------------|--------------|------------|--------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm   | 1.1<br>0.8 | 0.1                   | 0.4<br>0.3     | 0.7<br>0.5     | 0.25<br>0.10 | 2.2<br>1.8 | 1.35<br>1.15 | 1.3 | 1.15           | 2.2<br>2.0     | 0.45<br>0.15   | 0.23<br>0.13 | 0.2 | 0.2 | 0.1 |

| OUTLINE<br>VERSION | REFERENCES |       |      |  | EUROPEAN<br>PROJECTION | ISSUE DATE           |
|--------------------|------------|-------|------|--|------------------------|----------------------|
|                    | IEC        | JEDEC | EIAJ |  |                        |                      |
| SOT343R            |            |       |      |  |                        | 97-05-21<br>06-03-16 |

## N-channel dual-gate MOS-FETs

## BF1212; BF1212R; BF1212WR

## DATA SHEET STATUS

| DOCUMENT STATUS <sup>(1)</sup> | PRODUCT STATUS <sup>(2)</sup> | DEFINITION                                                                            |
|--------------------------------|-------------------------------|---------------------------------------------------------------------------------------|
| Objective data sheet           | Development                   | This document contains data from the objective specification for product development. |
| Preliminary data sheet         | Qualification                 | This document contains data from the preliminary specification.                       |
| Product data sheet             | Production                    | This document contains the product specification.                                     |

## Notes

1. Please consult the most recently issued document before initiating or completing a design.
2. The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

## DEFINITIONS

**Product specification** — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

## DISCLAIMERS

**Limited warranty and liability** — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of NXP Semiconductors.

**Right to make changes** — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

**Suitability for use** — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

**Applications** — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

---

N-channel dual-gate MOS-FETsBF1212; BF1212R; BF1212WR

---

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

**Limiting values** — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

**Terms and conditions of commercial sale** — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at <http://www.nxp.com/profile/terms>, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

**No offer to sell or license** — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

**Export control** — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

**Quick reference data** — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

**Non-automotive qualified products** — Unless this data sheet expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

# **NXP Semiconductors**

***provides High Performance Mixed Signal and Standard Product solutions that leverage its leading RF, Analog, Power Management, Interface, Security and Digital Processing expertise***

## **Customer notification**

This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content, except for package outline drawings which were updated to the latest version.

## **Contact information**

For additional information please visit: <http://www.nxp.com>

For sales offices addresses send e-mail to: [salesaddresses@nxp.com](mailto:salesaddresses@nxp.com)

© NXP B.V. 2010

All rights are reserved. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner.

The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice. No liability will be accepted by the publisher for any consequence of its use. Publication thereof does not convey nor imply any license under patent- or other industrial or intellectual property rights.

Printed in The Netherlands

R77/02/pp16

Date of release: 2003 Nov 14

Компания «Океан Электроники» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Поставка оригинальных импортных электронных компонентов напрямую с производств Америки, Европы и Азии, а так же с крупнейших складов мира;
- Широкая линейка поставок активных и пассивных импортных электронных компонентов (более 30 млн. наименований);
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Помощь Конструкторского Отдела и консультации квалифицированных инженеров;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
- Поставка специализированных компонентов военного и аэрокосмического уровня качества (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Actel, Aeroflex, Peregrine, VPT, Syfer, Eurofarad, Texas Instruments, MS Kennedy, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Компания «Океан Электроники» является официальным дистрибьютором и эксклюзивным представителем в России одного из крупнейших производителей разъемов военного и аэрокосмического назначения «JONHON», а так же официальным дистрибьютором и эксклюзивным представителем в России производителя высокотехнологичных и надежных решений для передачи СВЧ сигналов «FORSTAR».



## JONHON

«JONHON» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«FORSTAR» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели,  
кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).



Телефон: 8 (812) 309-75-97 (многоканальный)

Факс: 8 (812) 320-03-32

Электронная почта: [ocean@oceanchips.ru](mailto:ocean@oceanchips.ru)

Web: <http://oceanchips.ru/>

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, д. 2, корп. 4, лит. А